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tes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/955,278	WANG ET AL.	
	Examiner	Art Unit	
	Jacob Meek	2637	

	SEARCHED			
Class	Subclass	Date	Examiner	
375	231,232	12/7/2005	JM	
333	18	12/7/2005	JM	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEAF	RCH STRATEGY)
	DATE	EXMR
East:: see search notes	12/7/2005	JM
NPL: eye opening	12/7/2005	JM